

<b>Notice of References Cited</b>	Application/Control No. 10/707,388		Applicant(s)/Patent Under Reexamination DIVAKARUNI ET AL.	
	Examiner Steven J. Fulk		Art Unit 2891	Page 1 of 2

U.S. PATENT DOCUMENTS					
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0135214	07-2004	Ballantine et al.	257/379
*	B	US-6,255,185	07-2001	Coolbaugh et al.	438/382
*	C	US-4,748,491	05-1988	Takagi, Hiroshi	257/538
*	D	US-6,069,398	05-2000	Kadosh et al.	257/538
*	E	US-5,893,731	04-1999	Lee et al.	438/238
*	F	US-5,705,436	01-1998	Chin et al.	438/238
*	G	US-6,211,030	04-2001	Liou, Fu-Tai	438/382
*	H	US-6,933,186	08-2005	Cotte et al.	438/190
*	I	US-4,451,328	05-1984	Dubois, Guy	438/385
*	J	US-5,780,333	07-1998	Kim, Jae-Kap	438/238
*	K	US-6,340,833	01-2002	Liu et al.	257/536
*	L	US-2002/0113291	08-2002	Adkisson et al.	257/529
*	M	US-2003/0183880	10-2003	Goto et al.	257/379

FOREIGN PATENT DOCUMENTS						
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS		
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Wolf, "Silicon Processing for the VLSI Era: Process Integration," Volume II, 1990, pp. 146, 176, 193.
	V	Wolf, "Silicon Processing for the VLSI Era: Process Technology," Volume I, 1986, pp. 386-388, 399-400.
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>	Application/Control No. 10/707,388	Applicant(s)/Patent Under Reexamination DIVAKARUNI ET AL.	
	Examiner Steven J. Fulk	Art Unit 2891	Page 2 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0135214	07-2004	Ballantine et al.	257/379
*	B	US-6,359,339	03-2002	Gregor et al.	257/757
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.